

查询"2N7225"供应商

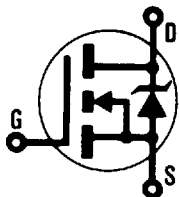
INTERNATIONAL RECTIFIER



REPETITIVE AVALANCHE RATED AND dv/dt RATED

HEXFET® TRANSISTOR

IRFM250
2N7225



N-CHANNEL

JANTX2N7225
JANTXV2N7225
(REF: MIL-S-19500/592)

200 Volt, 0.100 Ohm HEXFET

The HEXFET® technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance.

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

They are well suited for applications such as switching power supplies and virtually any application where military and/or high reliability is required.

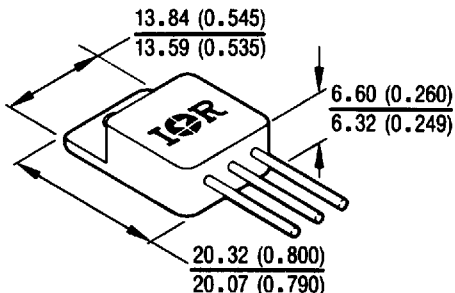
Product Summary

Part Number	BV _{DSS}	R _{DS(on)}	I _D
IRFM250	200V	0.100Ω	27.4A

FEATURES:

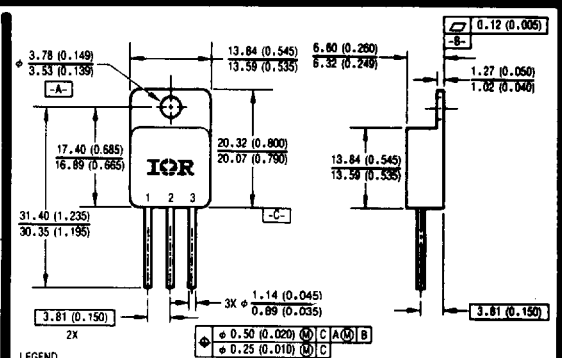
- Repetitive Avalanche Rating
- Isolated and Hermetically Sealed
- Alternative to TO-3 Package
- Simple Drive Requirements
- Ease of Paralleling
- Ceramic Eyelets

CASE STYLE AND DIMENSIONS



CAUTION

BERYLLIA WARNING PER MIL-S-19500
SEE PAGE I-324



- LEGEND:
1 DRAIN
2 SOURCE
3 GATE

- NOTES:
1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M - 1982
2 ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES)

Conforms to JEDEC Outline TO-254AA*
Dimensions in Millimeters and (Inches)

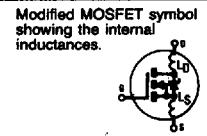
*For leadform configurations see page I-324, fig. 15

Absolute Maximum Ratings

Parameter	IRFM250, JANTXV, JANTX-, 2N7225	Units
I_D @ $V_{GS} = 10V, T_C = 25^\circ C$	Continuous Drain Current	27.4
I_D @ $V_{GS} = 10V, T_C = 100^\circ C$	Continuous Drain Current	17
I_{DM}	Pulsed Drain Current ①	110
P_D @ $T_C = 25^\circ C$	Max. Power Dissipation	150
	Linear Derating Factor	1.2
V_{GS}	Gate-to-Source Voltage	± 20
E_{AS}	Single Pulse Avalanche Energy ②	500 (See Fig. 12)
I_{AR}	Avalanche Current ①	27.4 (See E_{AR})
E_{AR}	Repetitive Avalanche Energy ①	15 (See Fig. 13)
dv/dt	Peak Diode Recovery dv/dt ③	5.0 (See Fig. 17)
T_J	Operating Junction Temperature Range	-55 to 150
T_{STG}	Storage Temperature Range	
	Lead Temperature	300 (0.063 in. (1.6 mm) from case for 10s)
	Weight	9.3 (typical)

Electrical Characteristics @ $T_J = 25^\circ C$ (Unless Otherwise Specified)


Parameter	Min.	Typ.	Max.	Units	Test Conditions
BV_{DSS}	200	—	—	V	$V_{GS} = 0V, I_D = 1.0 mA$
$\Delta BV_{DSS}/\Delta T_J$	—	0.28	—	V/ $^\circ C$	Reference to $25^\circ C, I_D = 1.0 mA$
$R_{DS(on)}$	—	—	0.100	Ω	$V_{GS} = 10V, I_D = 17A$ ④
	—	—	0.105		$V_{GS} = 10V, I_D = 27.4A$
$V_{GS(th)}$	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
g_{fs}	9.0	—	—	S (f)	$V_{DS} \geq 15V, I_{DS} = 17A$ ④
I_{DSS}	—	—	25	μA	$V_{DS} = 0.8 \times \text{Max. Rating}, V_{GS} = 0V$
	—	—	250		$V_{DS} = 0.8 \times \text{Max. Rating}$ $V_{GS} = 0V, T_J = 125^\circ C$
I_{GSS}	—	—	100	nA	$V_{GS} = 20V$
I_{GSS}	—	—	-100		$V_{GS} = -20V$
Q_g	55	—	115	nC	$V_{GS} = 10V, I_D = 27.4A$
Q_{gs}	8	—	22		$V_{DS} = 0.5 \times \text{Max. Rating}$
Q_{gd}	30	—	60		See Fig. 6 and 14
$t_d(on)$	—	—	35	ns	$V_{DD} = 100V, I_D = 27.4A, R_G = 2.35\Omega$
t_r	—	—	190		See Fig. 11
$t_d(off)$	—	—	170		
t_f	—	—	130		
L_D	—	8.7	—	nH	Measured from the drain lead, 6 mm (0.25 in.) from package to center of die.
L_S	—	8.7	—		Measured from the source lead, 6 mm (0.25 in.) from package to source bonding pad.
C_{iss}	—	3500	—	pF	$V_{GS} = 0V, V_{DS} = 25V$
C_{oss}	—	700	—		$f = 1.0 MHz$
C_{rss}	—	110	—		See Fig. 5
C_{DC}	—	12	—		





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Source-Drain Diode Ratings and Characteristics

Parameter	Min.	Typ.	Max.	Units	Test Conditions
I_S Continuous Source Current (Body Diode)	—	—	27.4	A	Modified MOSFET symbol showing the integral Reverse p-n junction rectifier. 
I_{SM} Pulsed Source Current (Body Diode) ①	—	—	110		
V_{SD} Diode Forward Voltage	—	—	1.9	V	$T_J = 25^\circ\text{C}$, $I_S = 27.4\text{A}$, $V_{GS} = 0\text{V}$ ④
t_{rr} Reverse Recovery Time	—	—	950	nS	$T_J = 25^\circ\text{C}$, $I_F = 27.4\text{A}$, $di/dt \leq 100\text{ A}/\mu\text{s}$ ④
Q_{RR} Reverse Recovery Charge	—	—	9.0	μC	$V_{DD} \leq 50\text{V}$
t_{on} Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$.				

Thermal Resistance

Parameter	Min.	Typ.	Max.	Units	Test Conditions
R_{thJC} Junction-to-Case	—	—	0.83	K/W ⑤	
R_{thCS} Case-to-Sink	—	0.21	—		Mounting surface flat, smooth, and greased
R_{thJA} Junction-to-Ambient	—	—	48		Typical socket mount

① Repetitive Rating; Pulse width limited by maximum junction temperature (see figure 9) Refer to current HEXFET reliability report

② @ $V_{DD} = 50\text{V}$, Starting $T_J = 25^\circ\text{C}$,
 $L \geq 1.0\text{ mH}$, $R_G = 25\Omega$,
 Peak $I_L = 27.4\text{A}$

③ $I_{SD} \leq 27.4\text{A}$, $di/dt \leq 190\text{ A}/\mu\text{s}$,
 $V_{DD} \leq BV_{DSS}$, $T_J \leq 150^\circ\text{C}$
 Suggested $R_G = 2.35\Omega$

④ Pulse width $\leq 300\mu\text{s}$; Duty Cycle $\leq 2\%$

⑤ $K/W = ^\circ\text{C}/\text{W}$
 $W/K = \text{W}/^\circ\text{C}$

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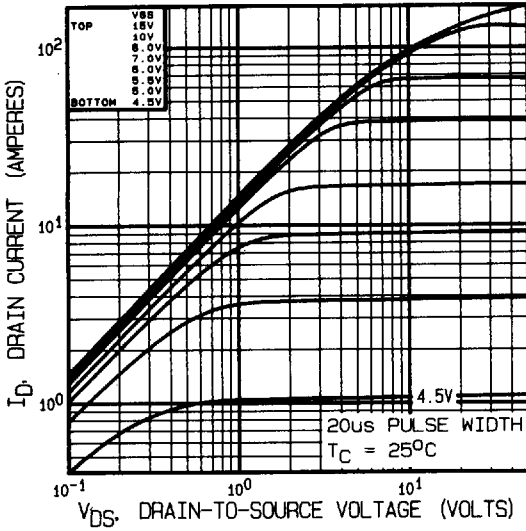


Fig. 1 — Typical Output Characteristics, $T_C = 25^\circ\text{C}$

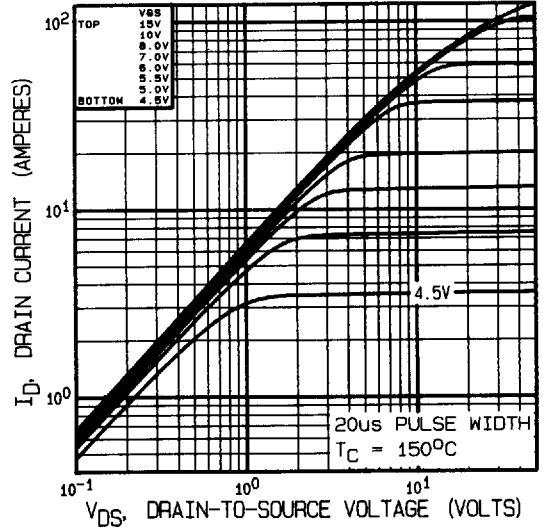


Fig. 2 — Typical Output Characteristics, $T_C = 150^\circ\text{C}$

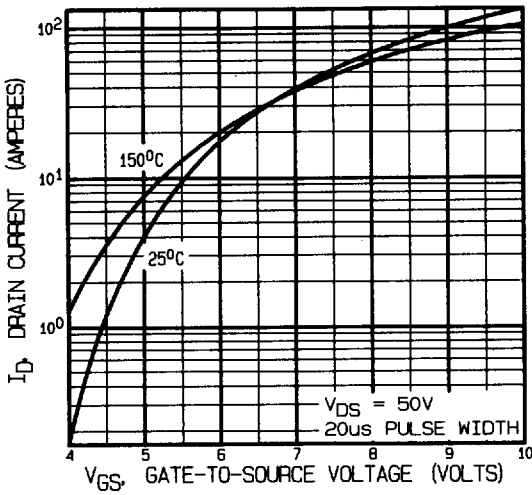


Fig. 3 — Typical Transfer Characteristics

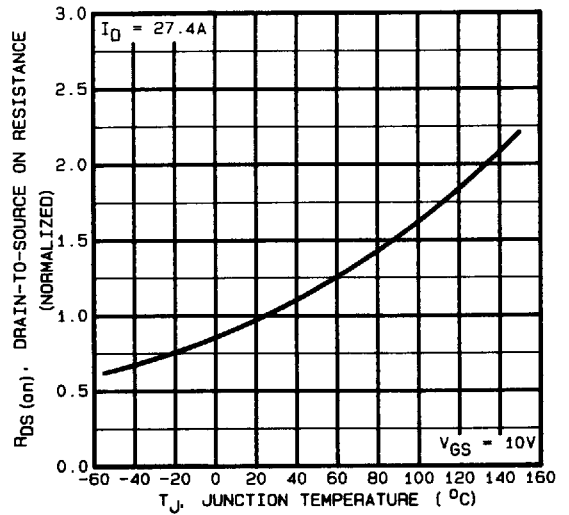


Fig. 4 — Normalized On-Resistance Vs. Temperature

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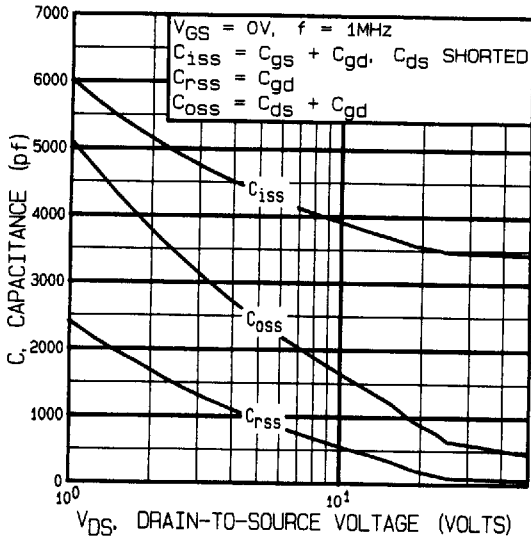


Fig. 5 — Typical Capacitance Vs. Drain-to-Source Voltage

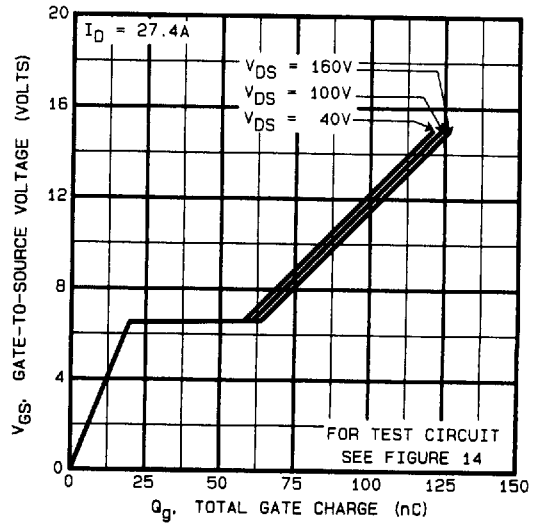


Fig. 6 — Typical Gate Charge Vs. Gate-to-Source Voltage

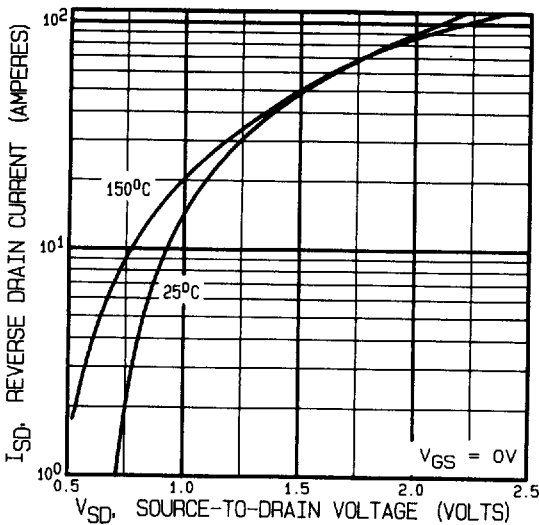


Fig. 7 — Typical Source-Drain Diode Forward Voltage

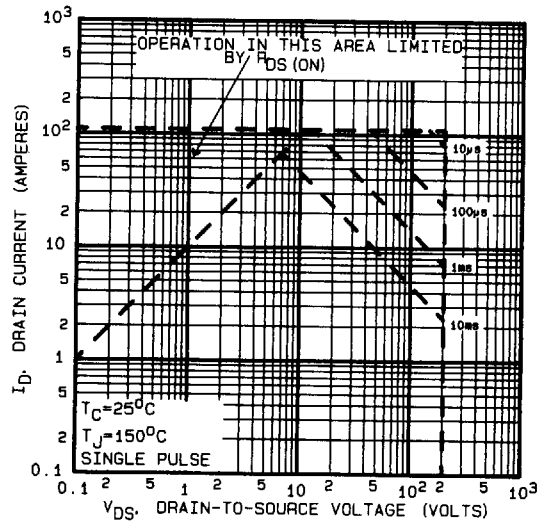


Fig. 8 — Maximum Safe Operating Area

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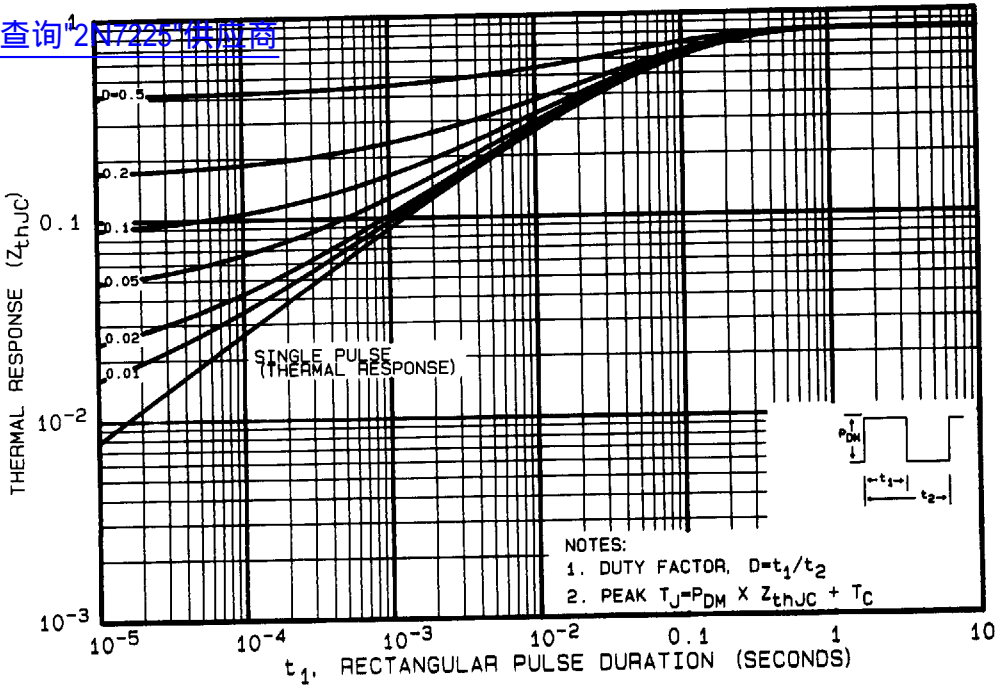


Fig. 9 — Maximum Effective Transient Thermal Impedance, Junction-to-Case Vs. Pulse Duration

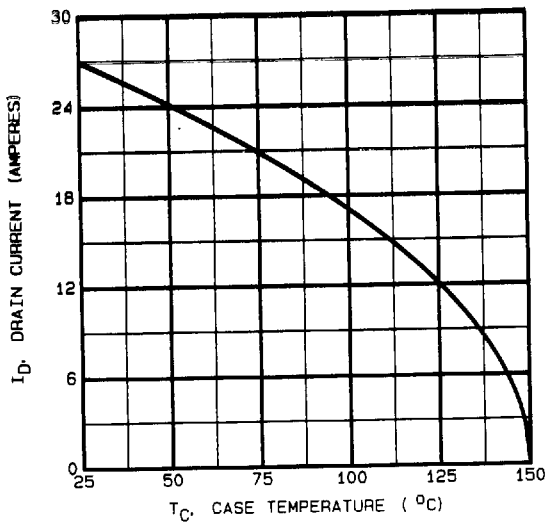


Fig. 10 — Maximum Drain Current Vs. Case Temperature

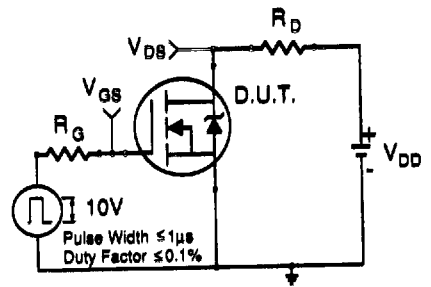


Fig. 11a — Switching Time Test Circuit

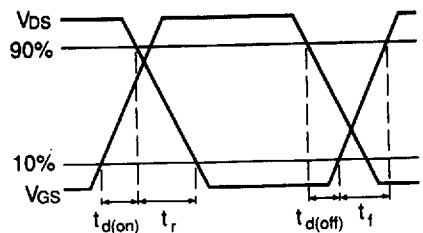


Fig. 11b — Switching Time Waveforms

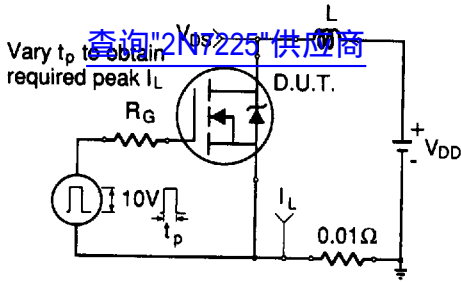


Fig. 12a — Unclamped Inductive Test Circuit

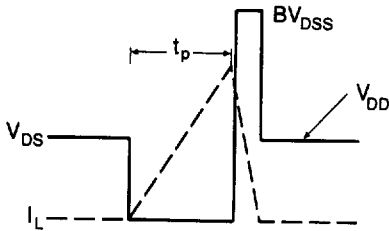


Fig. 12b — Unclamped Inductive Waveforms

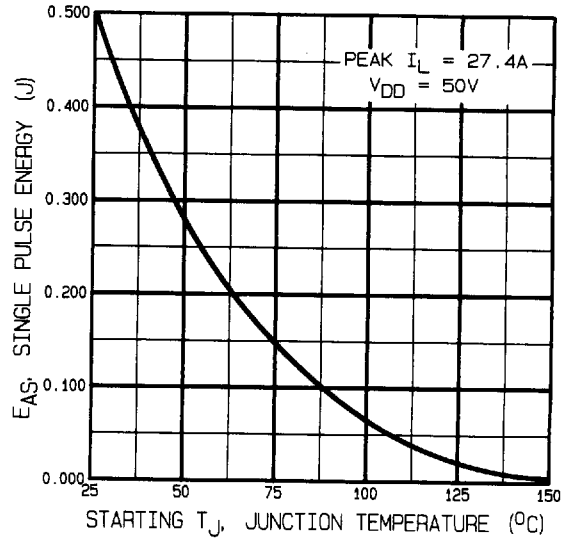


Fig. 12c — Maximum Avalanche Energy Vs. Starting Junction Temperature

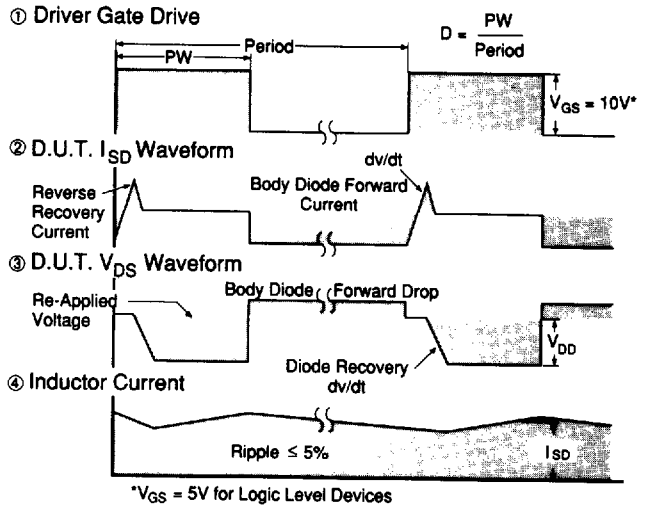
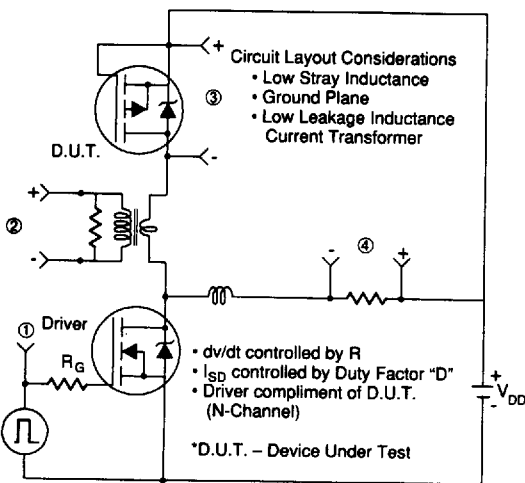


Fig. 13 — Peak Diode Recovery dv/dt Test Circuit

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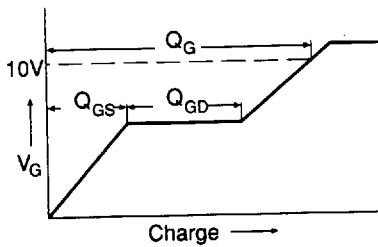


Fig. 14a — Basic Gate Charge Waveform

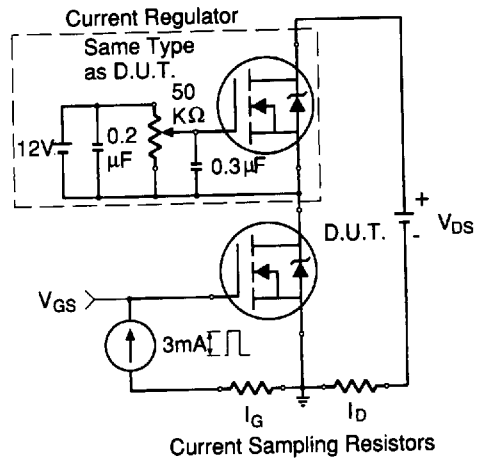


Fig. 14b — Gate Charge Test Circuit

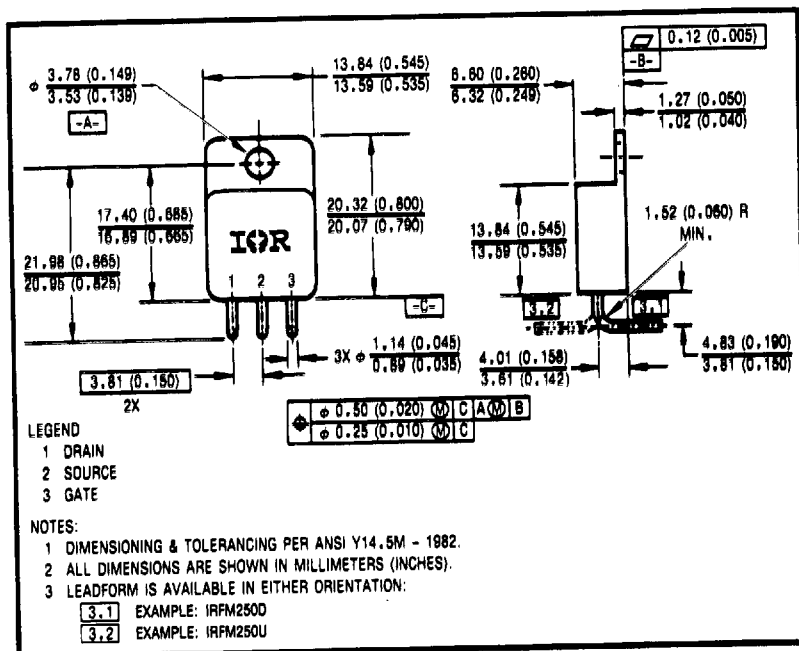


Fig. 15 — Optional Leadforms for Outline TO-254

BERYLLIA WARNING PER MIL-S-19500

Packages containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.